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Term:	('6338147' '6374236' '6427148') ! .PN.
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<u>L12</u>	('6338147' '6374236' '6427148') ! .PN.	3	<u>L12</u>
<u>L11</u>	L10 and (disk or dasd)	26	<u>L11</u>
<u>L10</u>	L9 and @ad<20010701	80	<u>L10</u>
<u>L9</u>	((plurality or multitude or set) adj2 message) with parallel	128	<u>L9</u>
<u>L8</u>	(plurality or multitude or set) adj2 message	16644	<u>L8</u>
<u>L7</u>	(plurality or multitude or set) adj2 meassage	1	<u>L7</u>
<u>L6</u>	((plurality or multitude or set) adj2 meassage) with parallel	0	<u>L6</u>
<u>L5</u>	(plurality or multitude or set) adj2 meassage	1	<u>L5</u>
<u>L4</u>	6128762.pn.	1	<u>L4</u>
<u>L3</u>	L2 and (group or collection or set)	1	<u>L3</u>
<u>L2</u>	5588117.pn.	1	<u>L2</u>
<u>L1</u>	swarm near3 message	1	<u>L1</u>

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 Terms used **swarm messages**

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1 [Hierarchical agent control: a framework for defining agent behavior](#)



Marc S. Atkin, Gary W. King, David L. Westbrook, Brent Heeringa, Paul R. Cohen

 May 2001 **Proceedings of the fifth international conference on Autonomous agents**

Publisher: ACM Press

 Full text available: [pdf\(229.02 KB\)](#)

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The Hierarchical Agent Control Architecture (HAC) is a general toolkit for specifying an agent's behavior. HAC supports action abstraction, resource management, sensor integration, and is well suited to controlling large numbers of agents in dynamic environments. It relies on three hierarchies: action, sensor, and context. The action hierarchy controls the agent's behavior. It is organized around tasks to be accomplished, not the agents themselves. This facilitates the integration of multi- ...

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